Search Notes



Application/Control No.

10658630

Applicant(s)/Patent Under Reexamination LEE ET AL.

Examiner

Goetze, Simon A

Art Unit

2617

SEARCHED

Class	Subclass	Date	Examiner
370	328	2/2/2007	SAG
370	338	2/2/2007	SAG
370	465	2/2/2007	SAG
370	466	2/2/2007	SAG
398	58	2/2/2007	SAG
398	59	2/2/2007	SAG
398	60	2/2/2007	SAG
398	61	2/2/2007	SAG
398	62	2/2/2007	SAG
398	63	2/2/2007	SAG
398	64	2/2/2007	SAG
REVIEW	ABOVE	11/21/2007	SAG

SEARCH	NOTES
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Search Notes	Date	Examiner
EAST image and keyword search (USPAT; US-PGPUB; USOCR; EPO; JPO; DERWENT; IBM_TDB).	2/2/2007	SAG
Consulted with Edan Orgad (Class 455), Chau T. Nguyen and Melvin Marcelo (both of 370).	2/2/2007	SAG
Consulted with Rafael Perez-Gutierrez (Class 455).	11/21/2007	SAG

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Class	Subclass	Date	Examiner
SEE	ATTACHED SEARCH HISTORY	11/21/2007	SAG